

# Instruction Manual LeCroy HFP1000

#### Warranty

LeCroy warrants this oscilloscope accessory for normal use and operation within specification for a period of one year from the date of shipment. Spare parts, replacement parts and repairs are warranted for 90 days.

In exercising its warranty, LeCroy, at its option, will either repair or replace any assembly returned within its warranty period to the Customer Service Department or an authorized service center. However, this will be done only if the product is determined by LeCroy's examination to be defective due to workmanship or materials, and the defect is not caused by misuse, neglect, accident, abnormal conditions of operation, or damage resulting from attempted repair or modifications by a non-authorized service facility.

The customer will be responsible for the transportation and insurance charges for the return of products to the service facility. LeCroy will return all products under warranty with transportation charges prepaid.

This warranty replaces all other warranties, expressed or implied, including but not limited to any implied warranty of merchantability, fitness or adequacy for any particular purposes or use. LeCroy shall not be liable for any special, incidental, or consequential damages, whether in contract or otherwise.

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HFP1000-OM-E Rev C 0301





# **Table of Contents**

Ā	Safety Information
<u>\i\</u>	Operator Safety1-1 Conventions Used in this Manual1-1
	Overview
	Product Description
	Features and Accessories
	Probe Head       3–1         AutoColor ID       3–1         Description of Standard and Optional Accessories       3–1         A. Tips       3–2         B. Clips       3–3         C. Leads       3–4         D. Probe Holder       3–5         E. Cartridges       3–6
	Operation
	Handling the Probe
	High Frequency Measurements
	Input Loading5-1 Inductive Loading (Lead Length)5-1 Capacitive Loading5-3
	Care and Maintenance
	Cleaning

	Replacement Parts	6-2
Р	Performance Verification	
	Test Equipment Required	
	Preliminary Procedure	
	Functional Check	
	Procedure	
	A. Output Zero Voltage	
	B. LF Attenuation Accuracy	/-5
A	Adjustment Procedure	
	Introduction	8–1
	Test Equipment Required	8–1
	Preliminary Procedure	8-2
	Procedure	8-3
	A. Adjust Output Zero	
	B. Verify Calibration	8-4
S	Specifications	
Ā	Nominal Characteristics	9–1
/!\	Warranted Characteristics	
	Typical Characteristics	9–1
	Environmental Characteristics	9-2
	Physical Characteristics	
	Compliance and Certifications	
		9–4
A	Appendix A	
	Performance Verification Test Record	A–1
	Equipment Used:	
	HFP1000 Test Record	

# 1 Safety Information

#### **OPERATOR SAFETY**

To avoid personal injury and to prevent damage to the probe or any products connected to it, review the following safety precautions. To avoid potential hazards, use the probe only as specified.



#### Warning



To avoid fire or personal injury, comply with the following:

Connect probe to the measurement instrument before connecting test leads to a voltage source.

Do not disconnect probe from instrument while test leads are connected to a voltage source.

Use of the probe and/or the oscilloscope it is connected to in a manner other than that specified may impair the protection mechanisms.

Do not apply a potential to any input that exceeds the maximum rating of that input. (Section 9, Specifications.)

When measuring high frequency signals, be sure to comply with the voltage vs. frequency derating curve. (Section 9, Specifications.)

Do not use in wet or explosive atmospheres.

Do not use the probe if any part is damaged. All maintenance should be referred to qualified service personnel.

#### **CONVENTIONS USED IN THIS MANUAL**

The following conventions may appear in this manual:

#### Note

A Note contains information relating to the use of the product.

#### **CAUTION**

A Caution contains information that should be followed to avoid possible damage to the instrument or the device under test.

#### **WARNING**

A Warning alerts you to a potential hazard. Failure to adhere to the statement in a WARNING message could result in personal injury.

The following symbols may appear on the product:



CAUTION: Refer to accompanying documents

This refers you to additional information contained in this manual. The corresponding information in the manual is similarly denoted.



CAUTION: Risk of electric shock

This is a reminder that high voltage may be present and that appropriate caution should be taken.



This is the symbol for earth ground.

###

# 2 Overview

#### PRODUCT DESCRIPTION

The 1 GHz HFP1000 is a small, high frequency active probe designed to meet today's increasing demand for measurements on a variety of test points.

With low input capacitance and high input resistance, circuit loading is minimized.

The HFP1000 can be used with LeCroy's WavePro<sup>™</sup>, Waverunner<sup>™</sup> and LC series oscilloscope with firmware version 8.7.0 or higher.

When the probe is used with any of these oscilloscopes, an Auto-Color ID feature automatically illuminates the probe head in the default trace color of the channel to which the probe is connected, eliminating the need for color bands or other markers.

With the ProBus interface, the HFP1000 becomes an integral part of the oscilloscope. The probe can be controlled from the oscilloscope's front panel. The oscilloscope provides power to the probe, so there is no need for a separate power supply or batteries.

When used in combination with an ADPPS power supply, the HFP1000 probe can be used with non-LeCroy instruments. (See Section 4 for detailed operation with an ADPPS adapter).

#### Note:

The AutoColor ID feature will be disabled when the probe is used with an ADPPS adapter or a LeCroy oscilloscope with firmware version lower than 8.7.0.

#### **KEY BENEFITS**

- · High frequency performance
- · Low input capacitance
- · Wide dynamic range
- · ProBus interface

- AutoColor feature matches the probe color to the oscilloscope's default trace color
- Five interchangeable tips for probing a variety of test points (two standard, three optional accessories)
- · Replaceable probe tip socket
- Hands free probing with optional FreeHand Probe Holder

#### **STANDARD ACCESSORIES**

The HFP1000 probe is shipped with the following standard accessories:

Item:	Quantity:
Straight Tip	4
Sharp Tip	4
Clip, 0.8 mm	2
Square Pin Ground Spring	1
Offset Pin	2
Short Right Angle Lead	1
Long Right Angle Lead	1
Short Single lead	1
Long Single Lead	1
Replaceable Cartridge	1
Instruction Manual	1
Certificate of calibration	1

#### **OPTIONAL ACCESSORIES**

The following items are available as optional accessories for the HFP1000 probe:

IC Lead Tip
SMD Discrete Tip
Bent Sharp Tip

Micro Clip Ground Spring with Hook FreeHand Probe Holder High Frequency Cartridge Soft Accessory Case

For part number information for standard and optional accessories refer to Section 6, Care and Maintenance, Replaceable Parts List.

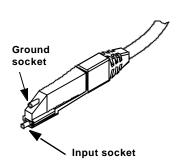
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# 3 Features and Accessories

The HFP1000 probe is provided with numerous features and accessories to make probing and connecting to different test points easier than ever.

#### **PROBE HEAD**



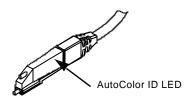
The small, low mass probe head is designed for ease of use and high performance.

The probe tip socket fits easily onto 0.025 inch square pins for direct access to test points. Several different adapters are available which connect directly in the probe socket.

The probe tip socket has a removable tip cartridge for easy replacement in case the probe socket gets damaged.

The ground socket will accept several different ground leads to provide a short ground path for high frequency performance.

#### **AUTOCOLOR ID**



The AutoColor ID consists of an LED inside the probe head which illuminates the probe body in the default trace color of the channel to which the probe is connected.

The AutoColor ID will only function when the probe is connected to a LeCroy oscilloscope supplied with the ProBus interface and firmware version 8.7.0 or higher. The colors are correct when factory default color scheme 1 is selected.

#### **DESCRIPTION OF STANDARD AND OPTIONAL ACCESSORIES**



The following Tip and Clip accessories can be pushed into the probe tip socket, ground socket or any other socketed lead or adapter.

#### A. Tips

#### **Straight Tip**



The straight tip is rugged and designed for general probing. Fits in either probe socket.

PACC-PT001, package of 4.

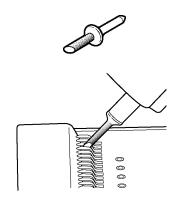
#### **Sharp Tip**



Rugged, titanium tip designed to connect to the smallest vias and small test points. Fits in either probe socket.

PACC-PT002, package of 4.

#### **IC Lead Tip**

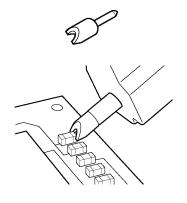


Covered in insulation on all sides (except for a small edge), this tip was designed to prevent shorting neighboring IC leads. The gold part of the tip is not insulated and should touch the IC lead to be tested. It is one-size-fits-all and will work with any IC lead pitch. Fits in either probe socket.

The IC Lead Tip is an optional accessory for the HFP1000.

PACC-PT003, package of 4.

#### **SMD Discrete Tip**



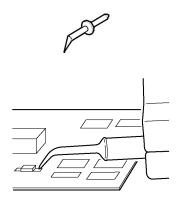
The crescent shape of this tip is designed to fit tightly on capacitors, resistors, transistors and other surface mount components with discrete leads. Fits in either probe socket.

The SMD Discrete Tip is an optional accessory for the HFP1000.

PACC-PT004, package of 4.

#### **Features and Accessories**

#### **Bent Sharp Tip**

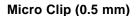


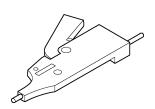
Made out of titanium, this tip is ideal for situations that require the user to hold the probe parallel to the circuit board under test. Also gives the user more control when holding the probe like a pencil. Fits in either probe socket.

The Bent Sharp Tip is an optional accessory for the HFP1000

PACC-PT005, package of 4.

#### **B.** Clips



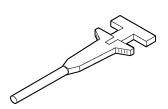


A pincher like tip designed to hold onto fine pitch leads and small components, commonly found in SMD ICs. Fits in either probe socket, or can be used with a lead.

The Micro Clip is an optional accessory for the HFP1000.

PACC-CL001, package of 4.

#### Clip (0.8 mm)

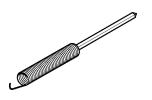


A pincher like tip designed to hold onto larger wires and components than possible with the Micro Clip, including through-hole mounted components.

This clip cannot be connected directly into either of the probe head sockets; it must be connected to a lead.

PK006-4, package of 2.

#### **Ground Spring with Hook**

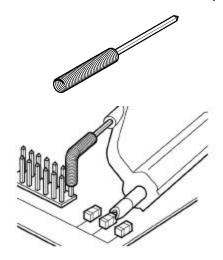


A flexible spring connected to a square pin that fits into either of the probe head sockets. Designed to be used as a ground lead, there is a hook on the end of the spring so that it can probe general circuits.

The Ground Spring with Hook is an optional accessory for the HFP1000.

PACC-LD001, package of 4.

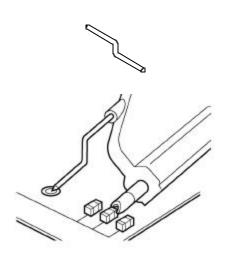
#### **Square Pin Ground Spring**



A flexible spring connected to a square pin that fits into either of the probe sockets. Designed to be attached to a square pin on the circuit under test.

PACC-LD002, package of 4.

#### **Offset Pin**



The offset pin is designed to be attached to either socket of the probe head. The offset pin is the highest quality grounding solution and is recommended in high frequency applications.

405400003, package of 1.

#### C. Leads

While longer leads provide greater flexibility when connecting the probe to a circuit, the added inductance may degrade the fidelity of high frequency signals. See Section 4 for additional information.

#### **Short and Long Right Angle Lead**



This lead has a socket on one end and a bent square pin on the other to connect to the input or ground socket of the probe body, and may be used for general purpose probing.

PACC-LD003 (short), PACC-LD004 (long), packages of 4.

#### **Short and Long Single Lead**



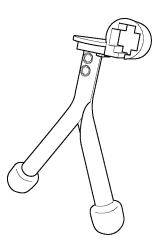
This lead can be used for either ground or input lead.

It has a socket on one end and a square pin on the other and may be used for general purpose probing.

PACC-LD005 (short), PACC-LD006 (long), packages of 4.

#### D. Probe Holder





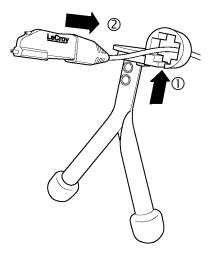
FreeHand lets you focus on the oscilloscope screen instead of on maintaining contact to multiple test points. It allows the user to concentrate on what is really important – the waveform.

It is designed to keep most of the weight on the probe tip and will prevent lost contact when a bump to the table shakes the circuit under test.

Additionally, the HFP probe can be mounted horizontally or vertically in the *FreeHand*, giving added measurement flexibility.

The *FreeHand* probe holder is an optional accessory for the HFP1000.

PACC-MS001, package of 1.

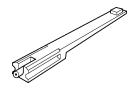


#### To use the FreeHand probe holder

- 1. Slide the probe cable through the slot on the bottom of the translucent holder section.
- 2. Slide probe backwards in the probe holder.

Installing probe into FreeHand

### E. Cartridges



#### Replaceable Cartridge

If the input tip socket gets damaged, you don't have to replace the entire probe, because the HFP series active probe has a removable tip socket cartridge.

PACC-MS002, package of 1.

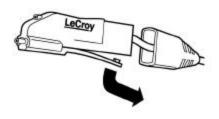
#### **High Frequency Cartridge**

By having a fixed tip rather than a socket, the High Frequency cartridge is able to increase signal fidelity at higher frequencies.

The High frequency cartridge is an optional accessory for the HFP1000.

PACC-MS003, package of 1.

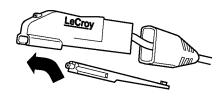
#### Removal and Installation of the Replaceable Cartridge



#### Removing old cartridge

#### To remove old cartridge:

- 1. Slide the cable strain relief over the cable away from the probe body.
- 2. To release the latch, lift the part closest to the strain relief away from the probe body and slide the cartridge toward the strain relief.



#### To install a new cartridge:

- 1. Slide the new cartridge onto the probe body until the latch engages.
- 2. Slide the cable strain relief forward to cover the back end of the probe body.

#### Installing new cartridge

#### Note:

The cable strain relief is polarized and fits over the probe body in one direction only.

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# 4 Operation

#### HANDLING THE PROBE

Exercise care when handling and storing the probe. Always handle the probe by the probe body or compensation box. Avoid putting excessive strain or exposing the probe cable to sharp bends.

#### CONNECTING THE PROBE TO THE TEST INSTRUMENT

The HFP1000 probe has been designed for use with LeCroy's WavePro™, Waverunner™ and LC oscilloscopes equipped with the ProBus interface. When you attach the probe output connector to the oscilloscope's input connector, the oscilloscope will recognize the probe, provide proper termination and activate the probe control functions in the user interface.

#### CONNECTING THE PROBE TO THE TEST CIRCUIT

To maintain the high performance capability of the probe in measurement applications, care must be exercised in connecting the probe to the test circuit. Increasing the parasitic capacitance or inductance in the input paths may introduce a "ring" or slow the rise time of fast signals. Input leads which form a large loop area will pick up any radiated electromagnetic field which passes through the loop and may induce noise into the probe input.

Using one of the available accessories makes the HFP1000 probe with its small profile and low mass head ideally suited for applications in dense circuitry.

#### **OPERATION WITH A LECROY OSCILLOSCOPE**

When the HFP1000 probe is connected to any LeCroy oscilloscope, the displayed scale factor and measurement values will be automatically adjusted.

Control through the oscilloscope's interface can be found in the 'Coupling' menu of the channel to which the probe is connected.

Turning the **Volts/Div** knob will control the oscilloscope's scale factor to give full available dynamic range up to 2 V/div.

#### **USE WITH NON-LECROY INSTRUMENTS**

The HFP1000 can be used with other instruments with the optional ADPPS power supply. The output of the ADPPS must be terminated into 50  $\Omega$ .

The AutoColor ID feature will be disabled when the probe is used with an ADPPS adapter.

#### **USE WITH OLDER LECROY INSTRUMENTS**

When used with LeCroy instruments with software version lower than 8.7.0, the oscilloscope will provide the correct scale factor but no AutoColor ID.

With V/div settings greater than 2 V/div, it is possible to display clipped waveforms on screen.

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**4–2** ISSUED: March 2001 HFP1000-OM-E Rev C

# **5 High Frequency Measurements**

#### **INPUT LOADING**

When you touch a probe to the circuit under test, the probe will affect your measurement because of the probe's input impedance introduced into the circuit. All probes present resistive, capacitive and inductive loading.

#### **INDUCTIVE LOADING (LEAD LENGTH)**

A significant element in this circuit is the inductance shown in the input ground leads of the oscilloscope probe.

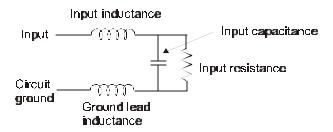


Figure 5-1. Probe Input Equivalent Circuit

The ground lead is the primary return path for the current resulting from the input voltage acting on the probe's input impedance. The ground lead and input lead inductances act with the probe's input capacitance to form series L-C network. The impedance of a series LC network will drop dramatically at its resonant frequency. This is the cause of the "ring" we often see after the leading edge of pulses in measured waveforms. This effect is referred to as ground lead corruption. Because it is impossible to eliminate either the L or C from this circuit, the method to improve waveform fidelity is to raise the resonant frequency beyond the bandwidth of interest in the measurement.

The resonant frequency of a simple LC circuit can be represented by:

$$F_{Resonance} = \frac{1}{2\pi\sqrt{LC}}$$

HFP1000-OM-E Rev C ISSUED: March 2001 **5–1** 

The resonant frequency of a series LC circuit can be raised by decreasing the inductance, capacitance or both.

Since the input capacitance is already very low and cannot be reduced, you can only try to reduce the inductance. This can be accomplished by using the shortest possible input lead as well as the shortest possible ground lead.

For example, to obtain the shortest possible ground lead when measuring IC related signals, attach a small piece of copper clad material to the top of the IC package and connect this to the package grounding wires. Using the shortest ground lead and input lead available makes probing signals on the package easier and makes for the shortest lead length for the best signal fidelity.

To illustrate how dramatic this effect is, we will work a simple example.

Assuming an input capacitance of 0.7 pF and a total lead length (input and ground) of 2 inches (inductance of  $\approx$  25 nH/inch) such a setup may cause ringing with a resonant frequency ( $f_0$ ) of:

$$f_0 = \frac{1}{2\pi\sqrt{50\times10^{-9}\times0.7\times10^{-12}}} = 851 \,\text{MHz}$$

This frequency is well within the passband of the probe and will therefore show up as part of the measured signal at faster time/ div settings.

To determine how fast a waveform to be measured can be without causing ringing on a probe like, this divide the BW (ringing frequency) of the probe into 0.35:

$$t_{rise} = \frac{0.35}{BW} = \frac{0.35}{851MHz} = 0.4 \, nsec$$

Any input signal with a rise time faster than 0.4 nsec can cause ringing.

#### **CAPACITIVE LOADING**

Capacitive loading is usually the most troublesome of the three loading effects.

It can affect the rise time, bandwidth and delay time measurements.

At higher frequencies the capacitive loading can affect the amplitude as well as the waveshape of the measured signal by introducing an exponential response to the waveform.

For a simple RC network the time constant of this exponential response is:

$$t_{rise} = 2.2 \times C_{total} \times R_{total}$$

where  $C_{total}$  is the combined probe and circuit capacitance and  $R_{total}$  is combined circuit and probe resistance.

For a setup where  $C_t$  = 0.7 pF and a source resistance is 250  $\Omega$ , the measured rise time will be 0.385 nsec, which will correspond to a bandwidth of 909 MHz, assuming no inductive loads.

$$(t_{rise} = 2.2 \times 0.7 \times 10^{-12} \times 250 \Omega = 0.385 \text{ nsec})$$

(parallel combination of 250  $\Omega$  and 100 k $\Omega$  is still 250  $\Omega$ )

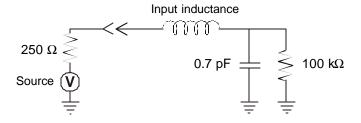


Figure 5-2. Probe input equivalent circuit

To illustrate the effect of capacitive loading at higher frequencies:

At a frequency of 851 MHz the reactance of the 0.7 pF capacitance is 267  $\Omega,$  and at 1.0 GHz the reactance has been lowered to 227  $\Omega$ 

HFP1000-OM-E Rev C ISSUED: March 2001 5–3

If, at a given frequency, the source impedance is large with respect to the input impedance, a measurable reduction in the output signal amplitude may occur.

$$V_{out} = \frac{Z_{probe}}{Z_{probe} + Z_{source}} \times V_{in}$$

where: Z<sub>probe</sub> is the probe's input impedance and

Z<sub>source</sub> is the source impedance

As an example:

At 851 MHz, where the probe input impedance has reduced to 267  $\Omega$ , and a source resistance of 250  $\Omega$  the probe output amplitude is reduced to:

$$V_{out} = \frac{267}{267 + 250} = 0.52 \times V_{in}$$

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# 6 Care and Maintenance

#### **CLEANING**

The exterior of the probe and cable should be cleaned only using a soft cloth lightly moistened with water or isopropyl alcohol. The use of abrasive agents, strong detergents, or other solvents may damage the probe. Always ensure that the input leads are free of debris.

#### Note

The probe case is not sealed and should never be immersed in any fluid.

#### **CALIBRATION INTERVAL**

The recommended calibration interval is one year. (Performance Verification and Adjustment Procedures are included in this manual.)

#### SERVICE STRATEGY

The HFP1000 probe utilizes fine pitch surface mount devices. It is therefore impractical to attempt to repair in the field. Defective probes must be returned to a LeCroy service facility for diagnosis and exchange. A defective probe under warranty will be replaced with a factory refurbished probe. A probe that is not under warranty can be exchanged for a factory refurbished probe for a modest fee. You must return the defective probe in order to receive credit for the probe core.

#### RETURNING A DEFECTIVE PROBE

The procedure for returning a defective probe is as follows:

Contact your local LeCroy sales representative to find out where to return the product. All returned products should be identified by model number and serial number. Provide your name and contact number and if possible describe the defect or failure. In case of products returned to the factory, a Return Authorization Number (RAN) should be used. The RAN can be established by contacting your nearest LeCroy office, or the New York Customer Care Center.

Return shipment should be made prepaid. LeCroy cannot accept COD or Collect Return shipments. We recommend air-freighting.

It is important that the RAN be clearly shown on the outside of the shipping package for prompt redirection to the appropriate department.

- Contact your local LeCroy sales or service representative to obtain a Return Authorization Number.
- Remove all accessories from the probe. Do not include the manual.
- 3. Pack the probe in its case, surrounded by the original packing material (or equivalent) and box.
- 4. Label the case with a tag containing
  - The RAN
  - · Name and address of the owner
  - Probe model and serial number
  - · Description of failure
- 5. Package the probe case in a cardboard shipping box with adequate padding to avoid damage in transit.
- 6. Mark the outside of the box with the shipping address given to you by the LeCroy representative; be sure to add the following:
  - · ATTN: <RAN assigned by the LeCroy representative>
  - FRAGILE
- 7. Insure the item for the replacement cost of the probe.
- 8. Ship the package to the appropriate address.

#### **REPLACEMENT PARTS**

The probe connection accessories and other common parts can be ordered through the regional customer care centers. Refer to list below for LeCroy part numbers. Defective probes can be replaced on an exchange basis. The replacement exchange probe will have been factory repaired, inspected and calibrated to the same standards as a new product. In order to obtain an exchange probe, you must return the defective probe. The returned probe should be sent back to the regional customer care center without any accessories, manual or case.

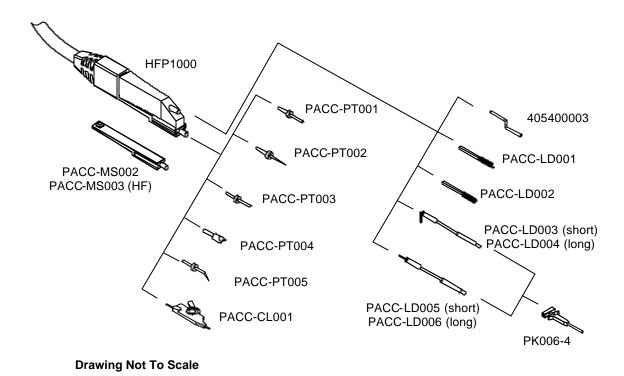


Figure 6-1. Replaceable Parts Selected by Input and Ground Accessory

(Some accessories may be optional and not included with the probe)

Table 6-1. Replaceable Parts List

Item	LeCroy P/N	Replacement Quantity
Straight Tip	PACC-PT001	4
Sharp Tip	PACC-PT002	4
IC Lead Tip	PACC-PT003	4
SMD Discrete Tip	PACC-PT004	4
Bent Sharp Tip	PACC-PT005	4
Micro Clip	PACC-CL001	4
Clip	PK006-4	2
Ground Spring with Hook	PACC-LD001	4
Square Pin Ground Spring	PACC-LD002	4
Offset Pin	405400003	1
Short Right Angle Lead	PACC-LD003	4
Long Right Angle Lead	PACC-LD004	4
Short Single Lead	PACC-LD005	4
Long Single Lead	PACC-LD006	4
FreeHand Probe Holder	PACC-MS001	1
Replaceable Cartridge	PACC-MS002	1
Low C Cartridge	PACC-MS003	1
Soft Accessory case	SAC-01	1
Instruction Manual	HFP1500-OM-E	1

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# 7 Performance Verification

This procedure can be used to verify the warranted characteristics of the HFP1000 High Frequency Probe.

The recommended calibration interval for the model HFP1000 is one year. The complete performance verification procedure should be performed as the first step of annual calibration. Test results can be recorded on a photocopy of the Test Record provided in Appendix A at the end of the manual.

Performance verification can be completed without removing the probe covers or exposing the user to hazardous voltages. Adjustment should only be attempted if a parameter measured in the Performance Verification Procedure is outside the specification limits.

#### Note:

Adjustment should only be performed by qualified personnel.

This procedure tests the following specifications:

- Output Zero Voltage
- LF Attenuation Accuracy

#### **TEST EQUIPMENT REQUIRED**

Table 7-1 lists the test equipment and accessories (or their equivalents) that are required for performance verification of the HFP1000 Probe.

This procedure has been developed to minimize the number of calibrated test instruments required.

Only the parameters listed in **boldface** in the "Minimum requirements" column must be calibrated to the accuracy indicated.

Because the input and output connectors types may vary on different brands and models of test instruments, additional adapters or cables may be required.

**Table 7-1. List of Required Equipment** 

Description	Minimum Requirements	Test Equipment Examples
Digital Oscilloscope	ProBus interface	LeCroy WavePro960 or LeCroy LT344
Digital Multimeter (DMM) with test probe leads	4.5 digit DC: 0.1% Accuracy AC: 0.1% accuracy	Agilent Technologies 34401A or Fluke 8842A-09
Function Generator	Sine Wave output amplitude adjustable to 14.14 Vp-p (5 Vrms) into 1 $M\Omega$ at 70 Hz	Agilent Technologies 33120A or Stanford Research Model DS340
BNC Coaxial Cable (2 ea.)	Male to Male, 50 Ω, 36" Cable	Pomona 2249-C-36 or Pomona 5697-36
BNC Tee Connector	Male to Dual Female	Pomona 3285
Calibration Fixture	ProBus Extender Cable	LeCroy PROBUS-CF01
Terminator, Precision, BNC	50 Ω ± 0.05%	LeCroy TERM-CF01
Banana Plug Adapter (2 ea.)	Female BNC to Dual Banana Plug	Pomona 1269
BNC to Mini-grabber	BNC Male to Mini-grabber Cable, 36"	Pomona 5187-C-36

#### PRELIMINARY PROCEDURE

- 1. Connect the HFP1000 probe to the female end of the ProBus Extension Cable. Connect the male end of the ProBus Extension Cable to channel 1 of the oscilloscope.
- 2. Turn the oscilloscope on and allow at least 30 minutes warmup time for the HFP1000 and test equipment before performing the Verification Procedure.
- 3. Turn on the other test equipment and allow these to warm up for the time recommended by the manufacturer.
- While the instruments are reaching operating temperature, make a photocopy of the Performance Verification Test Record (located in Appendix A), and fill in the necessary data.
- 5. Select the channel to which the probe is connected. Set the oscilloscope scale factor to 20 mV/div.

- Disconnect the ProBus Extender Cable from the oscilloscope. Verify that the scale factor changes from 20 mV/div to 2 mV/div.
- 7. Re-connect the ProBus extender Cable to the oscilloscope.

The warranted characteristics of the HFP1000 are valid at any temperature within the Environmental Characteristics listed in the Specifications. However, some of the other test equipment used to verify the performance may have environmental limitations required to meet the accuracy needed for the procedure. Make sure that the ambient conditions meet the requirements of all the test instruments used in his procedure.

#### Note

The correct operation of the HFP1000 controls requires software version 8.7.0 or higher. The software version in the test oscilloscope can be verified by pushing **SCOPE STATUS**, then selecting the **System** menu option.

Contact your local LeCroy representative if the software in your oscilloscope requires updating.

#### **FUNCTIONAL CHECK**

The functional check will verify the basic operation of the probe functions.

It is recommended the Functional Check be performed prior to the Performance Verification Procedure.

- 1. Return to the factory default settings by:
  - a. Pressing the oscilloscope's front panel **PANELS** button.
  - b. From the Menu buttons press FROM DEFAULT SETUP.
- 2. Select Channel 1 and enter the **Coupling** menu.
- 3. Verify that **Probe sensed (HFP1000)** is displayed on the right hand menu.
- 4. If the trace colors have been reassigned or you are unsure, restore the default colors by pressing the following menus:

HFP1000-OM-E Rev C ISSUED: March 2001 7–3

**DISPLAY, More Display Setup, Color Scheme** and in the Color Scheme menu press 1.

- 5. Verify that the probe head LED shows basically the same color as the channel 1 trace color.
- 6. Disconnect the probe from channel 1 and connect respectively to channel 2, 3 and 4.
- 7. Verify that in each case the LED color corresponds to the trace color of the channel to which the probe is connected.

#### **PROCEDURE**

#### A. Output Zero Voltage

- 1. Connect one end of a BNC cable to the female BNC connect tor on the probe end of the ProBus extender cable. Connect the precision 50  $\Omega$  terminator to the other end of the BNC cable.
- Connect the banana plugs of the Precision terminator to the input of the DMM. Make sure that the plug corresponding to the BNC shield (marked "Ground") is connected to the LO or COMMON input of the DMM. Refer to figure 7-1 for setup information.

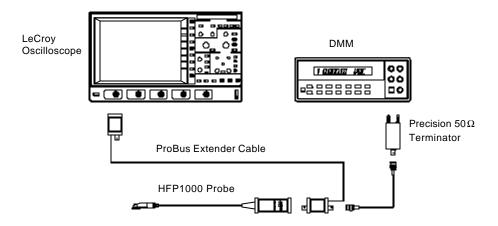


Figure 7-1. Output Zero Voltage Test Setup

- 3. Set the **OFFSET** on the oscilloscope to zero, as indicated by on-screen display.
- 4. Set the DMM to read DC Volt on the most sensitive range.
- 5. Record the voltage measured on the DMM to 10  $\mu V$  resolution as 'Output Zero Voltage' in the Test record.
- 6. Check that the voltage indicated by the DMM is between  $\pm 800~\mu\text{V}$ .
- 7. Disconnect the DMM from the precision 50  $\Omega$  terminator. Leave the remaining setup in place for the next step.

#### **B. LF Attenuation Accuracy**

1. Connect the BNC end of the BNC to mini-grabber cable to a female end of the BNC tee adapter. (Refer to figure 7-2)

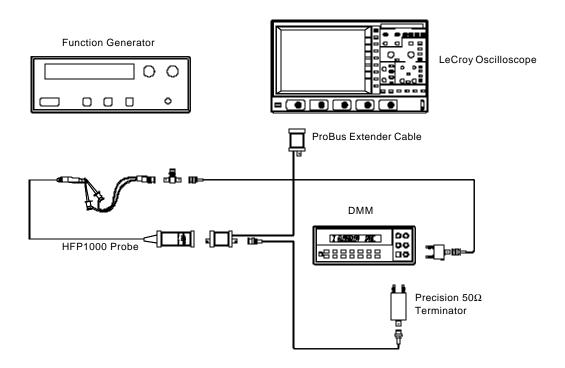


Figure 7-2. LF Attenuation Accuracy Test Setup

- Carefully insert the Straight Tips (supplied in accessory kit)
  into the sockets of the probe head. Attach the red lead of the
  mini-grabber to the signal input and the black lead to the
  ground input of the probe head.
- 3. Connect the BNC tee to the output of the function generator. (Use a 50  $\Omega$  termination if the function generator requires such a load).
- 4. Attach a BNC cable to the unused female port of the BNC tee and connect a dual banana plug adapter to the other end of the cable and plug the dual banana plug adapter into the DMM input. Make sure the side of the banana plug adapter corresponding to the BNC shield (marked "GROUND") is connected to the LOW or COMMON input of the DMM.
- 5. Set the DMM to read AC volt and set the range to measure 5.0 Vrms.
- Set the mode of the function generator to sine wave, the frequency to 70 Hz and the output amplitude to 5 Vrms ±10 mV as measured on the DMM.
- 7. Record the output voltage to 1 mV resolution as 'Generator Output Voltage' in the Test Record. Be careful not to alter the output amplitude after the reading is recorded.
- 8. Divide the reading recorded in step B-7 by 10 and record the result with 100  $\mu$ V resolution as 'Expected Output Voltage, top range" in the Test Record.
- 9. Remove the banana plug adapter, connected to the function generator, from the DMM and connect the precision 50  $\Omega$  terminator to the DMM, making sure that the banana plug side marked 'GROUND" is connected to the **LOW** or **COMMON** input of the DMM.
- 10. After the DMM reading has stabilized, record the reading to  $100\,\mu\text{V}$  resolution as 'Measured Output Voltage, top range' in the Test Record.
- 11. Calculate the error by dividing the measured top range output voltage recorded in step B10 by the expected top range output voltage recorded in step B-8. Subtract 1 from this ratio and multiply by 100% to get the error in percent.

**7–6** ISSUED: March 2001 HFP1000-OM-E Rev C

$$Error = \left(\frac{Measured\ Output\ Voltage}{Expected\ Output\ Voltage} - 1\right) ~100\%$$

- 12. Record the calculated error to two decimal places (±0.xx%) as 'Gain Error, top range' in the test record.
- 13. Verify that the error is less than ±1.0 %.
- 14. Disconnect the precision 50  $\Omega$  terminator from the DMM.
- 15. Connect the banana plug adapter connected via a BNC cable to the BNC tee at the function generator to the DMM. Verify that the side of the plug marked 'Ground' is connected to the LOW or COMMON input of the DMM.
- 16. Adjust the sine wave generator output amplitude to approximately 2.5 Vrms as measured on the DMM.
- 17. Record the reading to 1 mV resolution as 'Generator Output Voltage, mid range' in the Test Record. Be careful not to alter the output amplitude after the reading is recorded.
- 18. Divide the reading recorded in step B-17 by 10.
- 19. Record the result to 100  $\mu$ V resolution as 'Expected Output Voltage, mid range' in the test record.
- 20. Remove the banana plug adapter from the DMM and connect the precision 50  $\Omega$  terminator to the DMM, making sure that the banana plug side marked 'GROUND" is connected to the **LOW** or **COMMON** input of the DMM.
- 21. After the DMM has stabilized, record the reading to 100  $\mu V$  resolution as 'Measured Output Voltage, mid range' in the Test record.
- 22. Calculate the error by dividing the measured mid range output voltage recorded in step B-21 by the expected mid range output voltage recorded in step B-19. Subtract 1 from this ratio and multiply by 100% to get the error in percent.

HFP1000-OM-E Rev C ISSUED: March 2001 7–7

$$Error = \left(\frac{Measured\ Output\ Voltage}{Expected\ Output\ Voltage} - 1\right) ~100\%$$

- 23. Record the calculated error to two decimal places (±0.xx %) as 'Gain Error, mid range' in the Test record.
- 24. Verify that the mid range gain error is less than ±1.0%

This completes the Performance Verification of the HFP1000. Complete and file the Test Record, as required to support your internal calibration procedure.

Apply suitable calibration label to the HFP1000 housing as required.

###

## **8 Adjustment Procedure**

#### INTRODUCTION

You can use this procedure to adjust the HFP1000 probe to meet the warranted specifications. This procedure should only be performed if the probe fails to meet the Performance verification tests for Output Zero.

Gain which affects LF attenuation accuracy cannot be adjusted during routine calibration. Probes which fail LF attenuation accuracy during performance verification must be returned to the factory for rework.

If the probe cannot be adjusted to meet the Performance verification limits, repair may be necessary.

To assure probe accuracy, check the calibration of the HFP1000 every 1000 hours or once a year if used infrequently. Before calibration, thoroughly clean and inspect the probe as outlined in the Care and Maintenance section.

To assure the probe will meet the published specifications over the entire temperature range, adjustment must be performed in a controlled ambient environment with temperature of 23 °C ±5 °C.



### Caution

The adjustment procedure will require removal of the probe control circuitry cover. This cover is part of the ESD protection system of the HFP1000. To protect the probe, you should perform the entire procedure on a static dissipating work surface. Wear an antistatic wrist strap and follow standard static control procedures.

### **TEST EQUIPMENT REQUIRED**

Table 8-1 lists the test equipment and accessories (or their equivalents) that are required for complete calibration of the HFP1000 Probe. Specifications given for the test equipment are the minimum necessary for accurate calibration. All test equipment is assumed to be correctly calibrated and operating within the specification listed. Detailed operating instructions for the test equip-

HFP1000-OM-E Rev C ISSUED: March 2001 **8–1** 

### **HFP1000 High Frequency Probe**

ment are not given in this procedure. refer to the test equipment manual if more information is needed

If alternate test equipment is substituted, control settings or calibration equipment setups may need to be altered.

Table 8-1. List of Required Equipment

Description	Minimum Requirements	Test Equipment Examples
Digital Oscilloscope	ProBus interface	LeCroy LT344 or LeCroy LC584
Digital Multimeter (DMM) with test probe leads	4.5 digit DC: 0.1% Accuracy AC: 0.1% accuracy	Agilent Technologies 34401A or Fluke 8842A-09
BNC Coaxial Cable (2 ea.)	Male to Male, 50 Ω, 36" Cable	Pomona 2249-C-36 or Pomona 5697-36
Calibration Fixture	ProBus Extender Cable	LeCroy PROBUS-CF01
Terminator, Precision, BNC	50 Ω ± 0.05%	LeCroy TERM-CF01

### PRELIMINARY PROCEDURE

- 1. Remove the two screws that secure the plastic cover on the cable end of the ProBus interface housing.
- 2. Gently pull on the probe cable to slide the circuit board assembly from the metal housing.
- 3. Connect the HFP1000 probe to the female end of the ProBus extension cable, being careful to line up all six pins of the probe connector. Connect the male end of the ProBus extension cable to channel 1 of the oscilloscope.
- 4. Apply power to the oscilloscope and test equipment.
- 5. Allow at least 30 minutes warm-up time for the HFP1000 and test equipment before starting the calibration procedure.

### **PROCEDURE**

### A. Adjust Output Zero

- 1. Connect one end of a BNC cable to the probe end of the Pro-Bus extension cable. Connect the Precision 50  $\Omega$  Terminator to the other end of the BNC cable.
- 2. Connect the banana plugs of the precision  $50\,\Omega$  terminator to the input of the DMM. Make sure the plug corresponding to the BNC shield (marked 'Ground') is connected to the **LO** or **COMMON** input of the DMM. Refer to figure 8-1 for setup information.

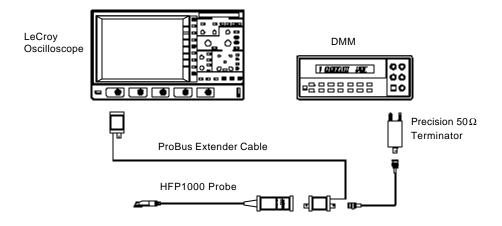


Figure 8-1 Output Zero Voltage Adjustment Setup

- Select the channel to which the probe and ProBus extender is connected. Set OFFSET on the oscilloscope to zero as indicated on the on-screen display.
- 4. Set the DMM to read DC Volt on the most sensitive range.
- 5. Verify that the probe inputs are not connected to any signal.
- 6. Adjust **OUTPUT ZERO** on the board until the DMM reads 0 V  $\pm 100 \,\mu$ V. Refer to figure 8-2 for adjustment location.

HFP1000-OM-E Rev C ISSUED: March 2001 **8–3** 

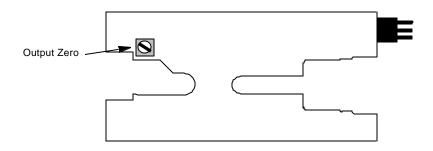


Figure 8-2 Adjustment Locations

Disconnect the probe from the ProBus extender and re-install
the circuit board into the probe case, being careful to align
the ProBus interface connector with the opening on the other
end of the probe.

### **B. Verify Calibration**

Repeat the Performance Verification procedure to ensure compliance with the warranted specifications.

Apply a calibration sticker, if required, in accordance with your quality control procedures.

###

## 9 Specifications

### NOMINAL CHARACTERISTICS

Nominal characteristics describe parameters and attributes that are guaranteed by design, but do not have associated tolerances.

± 8 V

Input Dynamic range

ware version 8.7.0 or higher

### WARRANTED CHARACTERISTICS

Warranted characteristics are parameters with guaranteed performance. Unless otherwise noted, tests are provided in the Performance Verification Procedure for all warranted specifications.

Low Frequency Attenuation  $\pm 1\%$  plus uncertainty of 50  $\Omega$ 

Accuracy termination

Output Zero ≤ 8 mV referred to the input

### **TYPICAL CHARACTERISTICS**

Typical characteristics are parameters with no guaranteed performance. Tests for typical characteristics are not provided in the Performance Verification Procedure.

Output Zero  $\leq 4 \text{ mV}$ , referred to the input

 $\begin{array}{ll} \text{Bandwidth (Probe only)} & 1 \text{ GHz} \\ \\ \text{Rise Time} & \leq 350 \text{ ps} \\ \\ \text{Input Capacitance} & 0.7 \text{ pF} \\ \\ \text{DC Input Resistance} & 100 \text{ k}\Omega \\ \end{array}$ 

<sup>&</sup>lt;sup>1</sup> Subject to input voltage vs. frequency derating. See figure 9-1.

### **HFP1000 High Frequency Probe**

#### **ENVIRONMENTAL CHARACTERISTICS**

Temperature, operating 0 °C to 50 °C

Temperature, non-operating -40 °C to 71 °C

Relative Humidity 80% max up to 31 °C, decreas-

ing linearly to 20% max at 50 °C

#### PHYSICAL CHARACTERISTICS

Probe Head Size:

 Length
 61 mm (2.4 in)

 Width
 7.3 mm (0.29 in)

 Height
 13.1 mm (0.52 in)

Cable Length 1.3 m (51.1 in)

Weight:

Probe only 100 g (3.5 oz.)
Shipping 0.85 kg(1.87 labs)

Input Sockets Signal and ground sockets are

compatible with 0.635 mm (0.025 in) square pins, and 0.91 mm (0.036 in) maximum

diameter round pins

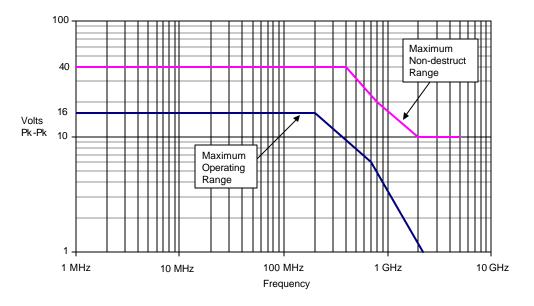


Figure 9-1. Input Voltage vs. Frequency

### **COMPLIANCE AND CERTIFICATIONS**

### **CE Declaration of Conformity**



Low Voltage Directive: EN 61010-1:1993+Amd2:1995

Safety requirements for electrical equipment for mea-

surement control and laboratory use. Part 1: General requirements.

EN61010-2-031:1994

Particular requirements for hand-held probe assemblies

for electrical measurement and test.

EMC Directive: EN 61326-1:1997+Amd1:1998

EMC requirements for electrical equipment for measure-

ment control and laboratory use.

Electromagnetic Emissions: EN 55011:1998 Class A Radiated Emissions.

Electromagnetic Immunity: EN 61000-4-2:1995 Electrostatic Discharge.

(Air/Contact Discharge: 4 kV)

EN 61000-4-3:1996 RF Radiated Electromagnetic

Field (80 MHz...1 GHz; 3 V/m)

###

## Appendix A

### PERFORMANCE VERIFICATION TEST RECORD

This record can be used to record the results of measurements made during the performance verification of the HFP1000 High Frequency Probe.

Photocopy this page and record the results on the copy. File the completed record as required by applicable internal quality procedures.

The section in the test record corresponds to the parameters tested in the performance verification procedure. The numbers preceding the individual data records correspond to the steps in the procedure that require the recording of data. Results to be recorded in the column labeled "Test Result" are the actual specification limit check. The test limits are included in all of these steps. Other measurements and the results of intermediate calculations that support the limit check are to be recorded in the column labeled "Intermediate Results".

Permission is granted to reproduce these pages for the purpose of recording test results.

Probe Model:	HFP1000
Serial Number:	
Asset or Tracking Number:	
Date:	
Technician:	

### **EQUIPMENT USED:**

	MODEL	SERIAL NUMBER	CALIBRATION DUE DATE
OSCILLOSCOPE			
DIGITAL MULTIMETER			
FUNCTION GENERATOR <sup>1</sup>			N/A

<sup>&</sup>lt;sup>1</sup>The function generator used in this Performance Verification Procedure is used for making relative measurements. The output of the generator is measured with a DMM or oscilloscope in this procedure. Thus, the generator is not required to be calibrated.

# **HFP1000 High Frequency Probe**

### **HFP1000 TEST RECORD**

Step	Description	Intermediate data	Test Result
Output	Zero Voltage		
A-5	Output Zero Voltage (Test limit $\leq \pm 800 \ \mu$	V)	V
LF Atte	enuation Accuracy		
B-7	Generator Output Voltage	,	V
B-8	Expected Output Voltage, top range		V
B-10	Measured Output Voltage, top range		V
B-12	Gain Error, top range (Test limit ≤± 1.0%	)	%
B-17	Generator Output Voltage		V
B-19	Expected Output Voltage, mid range		V
B-21	Measured Output Voltage, mid range		V
B-23	Gain Error, mid range (Test limit ≤± 1.0%	o)	%

###

### **DECLARATION OF CONFORMITY**

according to ISO/IEC Guide 22 and EN 45014:1998

Manufacturer's Name: LeCroy Corporation Manufacturer's Address: 700 Chestnut Ridge Road Chestnut Ridge, NY 10977

herewith declare that

Product(s) Name: Active Voltage Probe Model Number(s): HFP2500, HFP1500, HFP1000

are in conformity with the provisions of the following EC directive(s), including the latest amendments, and with national legislation implementing these directives:

> 73/23/EEC Low Voltage Directive 89/336/EEC EMC Directive

USA

and that conformity with Council Directive 73/23/EEC is based on

EN 61010-1: 1993+A2:1995 Safety requirements for electrical equipment for measurement control and

laboratory use

Part 1: General requirements

EN 61010-2-031: 1994 Part 2-031: Particular requirements for hand-held probe assemblies for

electrical measurement and test

and that conformity with Council Directive 89/336/EEC is based on

FN 61326-1: 1997+A1: 1998 EMC requirements for electrical equipment for measurement control and

laboratory use

EN 55011:1998 Class A Radiated Emissions Emissions:

EN61000-4-2: 1995 Immunity: Electrostatic Discharge

(Air/Contact Discharge: 4 kV)

RF radiated Electromagnetic Field EN 61000-4-3: 1996

(80 MHz.... 1 GHz; 3 V/m)

R. Kalyandrug By:

Product Compliance manager

LeCroy Corporation 700 Chestnut Ridge Road

Rledgarding

Chestnut Ridge, NY 10977

USA

Place:

**European Contact:** 

Your local LeCroy Sales Office or

LeCroy Europe GmbH Waldhofer Str. 104 D-69123 Heidelberg

Germany

November 22, 2000 Tel: (49) 6221 82700 Fax: (49) 6221 834655

Warning: This is a Class A product. In a domestic environment this product may cause radio interference, in which case the user may be required to take adequate measures.

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